

AM29C821A/BLA

High-Performance CMOS Bus Interface Registers

The Am29C821A and Am29C82311 CMOS Bus Interface Registers are designed to eliminate the extra devices required to buffer stand alone registers and to provide extra data width for wider address/data paths or buses carrying parity.

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer (OCM).

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

Advanced Micro Devices

Am29C821A/Am29C823A

High-Performance CMCS Bus Interface Registers

DISTINCTIVE CHARACTERISTICS

- Proprietary edge-rate controlled outputs dramatically reduce undershoots, overshoots and ground bounce
- High-speed parallel positive edge-triggered registers with D-type flip-flops
 - CP-Y propagation delay = 5 r s lypical
- Low standby power
- Very high output drive
 - IoL = 48 mA Commercial, 32 nm. Military

- Extra-wide (9- and 10-bit) data paths
- Power-up/down disable circuit provides for glitch-free power supply sequencing
- Can be powered off while in 3-state, ideal for card edge interface applications
- Minimal speed degradation with multiple outputs switching
- JEDEC FCT-compatible specs

GENERAL DESCRIPTION

The Am29C821A and Am29C823A CMOS Bus Interface Registers are designed to eliminate the extra devices required to buffer stand alone registers and to provide extra data width for wider address/data paths or buses carrying parity. The Am29C800A registers are produced with AMD's exclusive CS115A CMOS process, and feature typical propagation delays of 5 ns, as well as an output current drive of 48 reA

The Am29C821A is a buffered, 10 bir version of the popular '374/'534 function. The Am29C823A is a 9-bit buffered register with Clock Enable EN) and Clear (CLR)—ideal for parity bus in emacing in high-performance microprogrammed systems

The Am29C821A and Am29C823A interpretate AMD's proprietary edge-controlled outputs interder to minimize simultaneous switching noise (ground bounce), undershoots and overshoots. By controlling the output transient currents, ground bounce and output ringing have

been greatly reduced. A modified AMD output provides a stable, usable voltage level in less time than a non-controlled output.

Additionally, speed degradation due to increasing number of outputs switching is reduced. Together, these benefits of edge-rate control result in significant increase in system performance despite a minor increase in device propagation delay.*

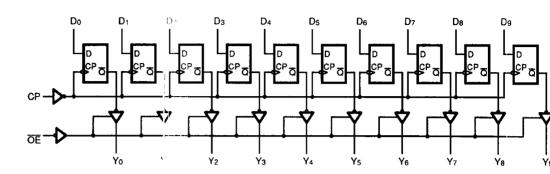
A unique I/O circuitry, which utilizes n-channel pull-up transistors (eliminating the parasitic diode to Vcc), provides for high-impedance outputs during power-off and power-up/down sequencing, thus providing glitch-free operation for card-edge and other active bus applications.

The Am29C821A and Am29C823A are available in the standard package options: DIPs, PLCCs, and SOICs.

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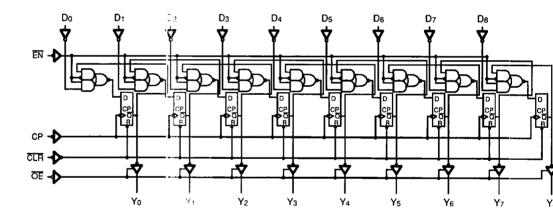
^{*}For more details refer to a Minimization and Prounce Bounce Through Output Edge-Rate Control Application Note (See Chapter 3).

BLOCK DIAGRAMS Am29C821A



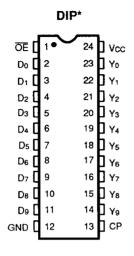
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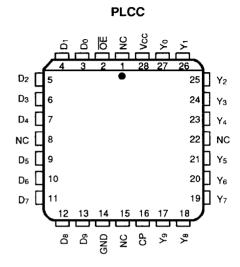
Am29C823A



11227-002A

CONNECTION DIAGRAMS (Top View) Am29C821A

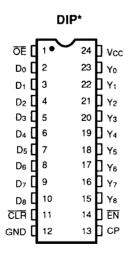


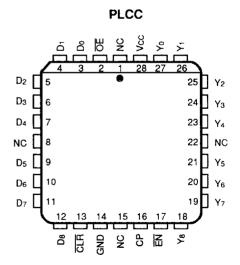


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Am29C823A





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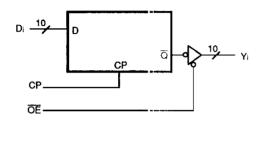
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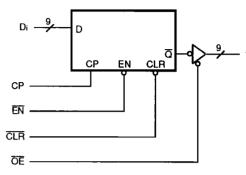
^{*}Also available in 24-Pin Small Outline package; pinout identical to DIPs.

LOGIC SYMBOLS

Am29C821A

Am29C823A





11227-007A

11227-008

FUNCTION TABLES

Am29C821A

	Inputs	_	Internal	Outputs	
ŌĒ	D	СР	Q i	Yı	Function
Н	L	1	н	Z	
Н	Н	↑	L	Z	Hi-Z
L	L	<u></u>	Н	L	
L	H	1	L	Н	Load

Am29C823A

		Iriputs			Internal	Outputs		
ŌĒ	CLR	EN	Di	CP	Qi	Yi	Function	
Н	Н	l	Ļ	<u> </u>	Н	Z		
Н	Н	L	Н	1	L	Z	Hi-Z	
Н	L	Х	Х	Х	Н	Z		
L	L	Х	Х	Х	Н	L	Clear	
Н	Н	H	Х	Х	NC	Z		
L	Н	Н	Х	Х	NC	NC	Hold	
H	Н	L	L	1	Н	Z		
Н	Н	L	H	1	L	Z	l	
L	Н	L	L	_ ↑	Н	L	Load	
L	Н	L_	Н		L	Н		

H = HIGH

NC = No Change

L= LOW

↑ = LOW-to-HIGH Transition

X = Don't Care

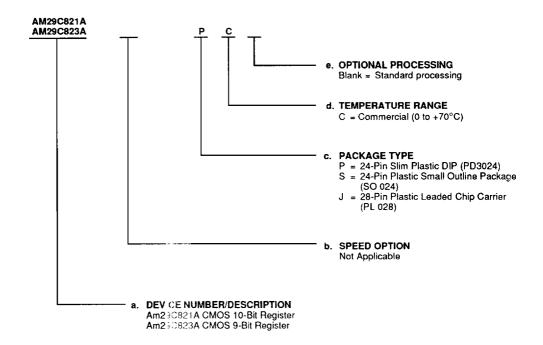
Z = High Impedance



ORDERING INFORMATION **Standard Products**

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of: a. Device Number

- b. Speed Option (if applicable)
- c. Package Type
 d. Temperature Range
- e. Optional Processing



Valid Combinations						
AM29C821A	DO 600 100					
AM29C823A	PC, SD, JC					

Valid Combinations

Valid Combinations fist configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific: valid combinations or to check on newly released combinations, and to obtain additional data on AMD's standard military grade products.

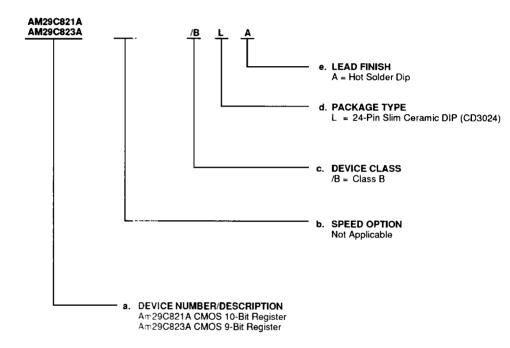


MILITARY ORDERING INFORMATION **APL Products**

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883C requirements. The order number (Valid Combination) is formed by a combination of:

a. Device Number

- Speed Option (if applicable)
 Device Class
 Package Type
 Lead Finish
- c. d.



Valid Combinations						
AM29C821A	.DV A					
AM29C823A	∃BLA					

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, or to check on newly released combinations.

Group A Tests

Group A tests consist of Subgroups 1, 2, 3, 7, 8, 9, 10, 11.

PIN DESCRIPTION Am29C821A/Am29C823A

D

Data input (input)

Di are the register data inputs.

CP

Clock Pulse (Input, LOW-to-HIGH Transition)

Clock Pulse is the clock input for the registers. Data is entered into the registers on the LOW-to-HIGH transitions.

Yi

Data Outputs (Output)

Yi are the three-state outputs.

OE

Output Enable (Input, Active LO'N)

When the \overline{OE} input is HIGH, the V_i outputs are in the high-impedance state. When \overline{OE} is LOW, the register data is present at the Y_i outputs.

Am29C823A only

EN

Clock Enable (Input, Active LOW)

When \overline{EN} is LOW, data on the Di inputs are transferred to the $\overline{Q_i}$ outputs on the LOW-to-HIGH clock transition. When \overline{EN} is HIGH, the $\overline{Q_i}$ outputs do not change state, regardless of the data or clock input transitions.

CLR

Clear (input, Active LOW)

When $\overline{\text{CLR}}$ is LOW, the internal register is cleared. When $\overline{\text{CLR}}$ is LOW and $\overline{\text{OE}}$ is LOW, the $\overline{\text{Qi}}$ outputs are HIGH. When $\overline{\text{CLR}}$ is HIGH, data can be entered into the register.



ABSOLUTE MAXIMUM RATINGS

-65 to +150°C StorageTemperature Supply Voltage to Ground **Potential Continous** -0.5 V to +7.0 V DC Output Voltage -0.5 V to +6.0 V DC Input Voltage -0.5 V to +6.0 V DC Output Diode Current: Into Output +50 mA Out of Output -50 mA DC Input Diode Current: Into Input +20 mA Out of Input -20 mA

DC Output Current:

Into Output +100 mA Out of Output -100 mA

Total DC Ground Current

(n x lot + m x loct) mA (Note 1)

Total DC Vcc Current (n x lon + m x loct) mA (Note 1)

Note:

1. n = number of outputs, m = ncmber of inputs.

Stresses above those listed uncer Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Ambient Temperature (T_A) 0 to +70°C Supply Voltage (Vcc) +4.5 to +5.5 V

Military (M) Devices

Ambient Temperature (T_A) -55 to +125°C Supply Voltage (Vcc) +4.5 to +5.5 V

Operating ranges define those limits between which the functionality of the device is guaranteed.



DC CHARACTERISTICS over operating ranges unless otherwise specified (for APL Products, Group A, Subgroups 1, 2, 3 are tested unless otherwise noted)

Parameter Symbol	Parameter Description	Test Conditions			Min.	Max.	Unit
Vон	Output HIGH Voltage	Vcc = 4.5 V Vin = Vihor Vil			2.4		V
Vol	Output LOW Voltage	Vcc = 4.5 V	MIL IOL = 3	2 mA		0.5	>
		Vin = Vihor Vil	COM'L lou	= 48 mA		0.5	٧
ViH	Input HIGH Voltage	Guaranteed Input Logical HIGH Voltage for All Inputs (Note 1)			2.0		٧
VIL	Input LOW Voltage	Guaranteed Input Logical LOW Voltage for All Inputs (Note 1)				0.8	>
Vı	Input Clamp Voltage	Vcc = 4.5 V, lin = -18 mA				-1.2	>
l _{IL}	Input LOW Current	Vcc = 5.5 V, Vin = GND				-5	μΑ
lıн	Input HIGH Current	Vcc = 5.5 V, Vin = 5.5 V				5	μΑ
lozн	Output Off-State Current	Vcc = 5.5 V, Vo = 5.5 V				+10	μA
lozL	(High Impedance)	Vcc = 5.5 V, Vc	Vcc = 5.5 V, Vo = GND			-10	μΑ
Isc	Output Short-Circuit Surrent	Vcc = 5.5 V, Vo = 0 V (Note 2)			-60		mA
lcca	1,112,27452	-	VIN = Vcc or	MIL		1.5	mA
		Vcc = 5.5 V	GND	COM'L		1.2	1117
ICCT	Static Supply Currer t	Outputs Open	$V_{IN} = 3.4 V$	Data Input		1.5	mA/
						3.0	Bit
lccpt	Dynamic Supply Current	Vcc = 5.5 V (Note 3) Outputs O		Outputs Open		275	μA⁄
				Outputs Loaded		400	MHz/ Bit

Notes:

- 1. Input thresholds are tested in confibration with other DC parameters or by correlation.
- 2. Not more than one output shortec at a time. Duration should not exceed 100 milliseconds.
- 3. Measured at a frequency ≤ 10 MHz with 50% duty cycle.
- † Not included in Group A tests.



SWITCHING CHARACTERISTICS for light capacitive loading over operating ranges unless otherwise specified (for APL Products, Group A, Subgroups 9, 10, 11 are tested unless otherwise noted)

	Parameter Description			Commercial		Military		
Symbol			Test Conditions*	Min.	Max.	Min.	Max.	Unit
tры	Propagation Delay Clock to Yi			2	8.5	2	9.5	ns
tphL	(OE = LOW) (Note			3	8.5	3	9.5	ns
ts	Data to CP Setup Time			3		3		ns
tн	Data to CP Hold Time			2		2		ns
ts	Enable (EN 1) to GP Setup	Time		4	<u> </u>	4		ns
ts	Enable (EN_F) to GP Setup Time			4		4		ns
tн	Enable (EN) Hold T∉ne		C _L = 50 pF	0		0		ns
t PHL	Propagation Delay, Clear to Yi		$R_1 = 500 \Omega$	3	10	3	10.5	ns
trec	Clear (CLR_F) to CF Setup Time		$R_2 = 500 \Omega$	6		6		ns
tрwн	Clock Pulse Width	HIGH]	6		6		ns
tpwL	Clock Fulse Width	LOW		6		6		ns
tpwL	Clear Pulse Width	LOW		6		6		ns
tzн	Output Enable Time 진단 TL to Yi			1	8.5	1	9	ns
tzl				3	12	3	13	ns
tHZ	Output Disable Time ÖÉ 🥒 to Yi			2	8	2	8.5	ns
tLZ	Output Disable Time Or.		l	2	8	2	8.5	ns

SWITCHING CHARACTERISTICS for heavy capacitive loading over operating ranges unless otherwise specified (Note 2)

			Commercial		Mili		
Symbol	Parameter Description	Test Conditions*	Min.	Max.	Min.	Max.	Unit
tpLH	Propagation Delay Clicck to Yi		2	15.5	2	17.5	ns
t PHL	(OE = LOW) (Note	$C_L = 300 \text{ pF}$ $R_1 = 500 \Omega$ $R_2 = 500 \Omega$	3	15.5	3	17.5	ns
tzн	Output Enable Time Time to Yi		2	15	2	15.5	ns
tzı			3	18.5	3	19.5	ns
tHZ	Output Disable Tim : OF _ to Ye	CL = 5 pF	2	6.5	2	7	ns
tız	Output Disable Tim : OF - to Yi	$R_1 = 500 \Omega$ $R_2 = 500 \Omega$	2	6.5	2	7	ns

^{*}See Test Circuit and Waveforms listen in Chapter 2.

Notes:

^{1.} For more details refer to a Minim of thom of Ground Bounce Through Output Edge-Rate Control Application Note (See Chapter 3).

^{2.} These parameters are guarantee: by characterization but not production tested.